

# RA6M2 Group

## Capacitive Touch Low Power Guide

#### Introduction

This application note explains the electrostatic Capacity Touch measurement that uses the Asynchronous General-Purpose Timer (AGT) function and Low power mode (Deep Software standby mode) installed in RA6M2.

## **Target Device**

RA6M2 Group

## Contents

1.	Specification
1.1	Project description
1.2	Used Peripherals
1.3	CPU Operation Mode3
1.4	CTSU Operation Status4
1.5	Register settings4
1.6	File Configuration
2.	Operation Conditions
3.	Software Description
3.1	Operation image
3.2	FSP driver and middleware9
3.2.1	Standby SRAM Notes9
3.3	List of Constants10
3.4	List of Structures11
3.4.1	Reset source (r_user_warm_start.h)11
3.4.2	2 Deep Software Standby mode cancel source (r_user_warm_start.h)12
3.5	List of Variables
3.6	List of Functions
3.6.1	l qe_touch_main ()15
3.6.2	2 r_captouch_low_power_scan15
3.6.3	3 r_captouch_low_power_disable_rtc16
3.6.4	R_BSP_WarmStart
3.6.5	5 R_CAPTOUCH_LPM_Save
3.6.6	6 R_CAPTOUCH_LPM_Load
3.6.7	7 R_CAPTOUCH_LPM_IsPowerOnReset16
4.	Flowcharts



## RA6M2 Group

4.1	qe_touch_main ()17
4.2	r_captouch_low_power_scan ()19
4.3	r_captouch_low_power_disable_rtc ()20
4.4	R_BSP_WarmStart ()
4.5	R_CAPTOUCH_LPM_Save ()25
4.6	R_CAPTOUCH_LPM_Load ()25
4.7	R_CAPTOUCH_LPM_IsPowerOnReset ()26
5.	Current consumption
5.1	Operation Conditions
5.2	Measurement Environment
5.3	RA6M2 Cap Touch CPU board jumper settings29
5.4	RA6M2 Cap Touch CPU board
5.5	Environment to measure current consumption31
5.6	Setting to measure current consumption31
5.7	Current Consumption Results
5.8	Current Consumption Calculation Resalts
6.	Sample Code
7.	References
Re	vision History



#### 1. Specification

## 1.1 **Project description**

Sample code that this application note describes is confirmed to operate on RA6M2 Group Capacitive Touch Evaluation System (RTK0EG0021S01001BJ). The setting of this project is adjusted to R7FA6M2AF3CFB implemented on RA6M2 Group Capacitive Touch Evaluation System. Modify the device setting in the project when you use the other device.

#### 1.2 Used Peripherals

Table 1.1 lists the used peripherals in the sample code.

#### Table 1.1 Peripherals in the sample code

Used Peripherals	Functions	
Capacitive Touch Sensing Unit (CTSU)	- Measures electrostatic capacitance of the touch sensor.	
Data Transfer Controller (DTC)	<ul> <li>Transfers CTSUSSC, CTSUSO0 and CTSUSO1 setting value in RAM to CTSU register.</li> <li>Transfers CTSUSC and CTSURC counter in CTSU register to RAM.</li> </ul>	
Asynchronous General-Purpose Timer (AGT)	Timer used to cancel Deep Software Standby mode.	
Event Link Controller (ELC)	- Starts CTSU measurement by Snooze entry.	

## 1.3 CPU Operation Mode

Table 1.2 lists CPU mode used in this sample code.

#### Table 1.2 CPU operation mode

CPU operation mode	Transition condition
Normal mode (MCU startup and Touch	Transition from Reset state after 100ms timer has
measurement Start process)	elapsed in Deep Software Standby mode
Software Standby mode	Transition by API of r_lpm driver.
Snooze mode	Transition from AGT counter underflow in Software
	Standby mode
Normal mode (Touch measurement End process	Transition from CTSU measurement end interrupt in
and Touch On/Off detection process)	Snooze mode
Deep Software Standby mode	Transition by API of r_lpm driver.



## 1.4 CTSU Operation Status

Table 1.3 lists CTSU operation status used in this sample code.

#### Table 1.3 CTSU operation status

CTSU Operation Status	Transition condition
Stop	Reset status
Start (Suspended)	Enable power-saving function during wait state
Start	Start touch measurement
Stop	Stop CTSU module
Stop (Undefined)	Deep Software Standby mode

## 1.5 Register settings

Register settings changed from the reset value are shown below.

#### Table 1.4 Register settings

Function	Register	Value	Remarks
I/O Ports	P000PFS	0x00000000	
	P001PFS	0x00000000	
	P002PFS	0x00000000	
	P003PFS	0x00000000	
	P004PFS	0x00000000	
	P005PFS	0x00000000	
	P006PFS	0x00000000	
	P007PFS	0x00000000	
	P108PFS	0x00000000	
	P109PFS	0x00000000	
	P110PFS	0x00000000	
	P201PFS	0x00000000	
	P300PFS	0x00000000	
Battery Backup Function	VBTICTLR	0x00	
Realtime Clock (RTC)	RCR2	0x00	Set according to 26.6.7 "Initialization Procedure When RTC Is Not to Be Used" in RA6M2 Group User's Manual: Hardware.
	RCR4	0x01	RCKSEL bit (Count Source Select in normal operation mode): 1 LOCO is selected
Low Power Modes	SBYCR	0x8000	The settings for each bit are as follows.
			OPE bit (Output Port Enable): 0
			Set the address bus and bus control signals to the high-impedance state
			SSBY bit (Software Standby): 1 Deep Software Standby mode



		1	
	SNZCR	0x82	The settings for each bit are as follows.
			(In case of Snooze mode)
			RXDREQEN bit (RXD0 Snooze Request Enable) : 0
			Ignore RXD0 falling edge in Software Standby mode
			Ignore KADO falling edge in Software Standby mode
			SNZDTCEN bit (DTC Enable in Snooze mode) : 1
			Enable DTC operation
			SNZE (Snooze mode Enable) : 1
			Enable Snooze mode
	DPSBYCR	0x80	The settings for each bit are as follows.
		0,000	
			DEEPCUT[1:0] bits (Power-Supply Control): 0
			Supply power to the Standby SRAM, low-speed on-
			chip oscillator, AGTn, and USBFS resume detecting
			unit in Deep Software Standby mode
			IOKEEP bit (I/O Port Retention): 0
			When Deep Software Standby mode is canceled, clear
			the I/O ports to the reset state
			DPSBY bit (Deep Software Standby): 1
			Deep Software Standby mode
Clock	SOSCCR	0x01	SOSTP bit (Sub-Clock Oscillator Stop): 1
Generation			Stop the sub-clock oscillator
Circuit			
Onoun			



## **1.6 File Configuration**

Table 1.5 lists the file added or changed in the sample code generated by RA configurator and QE for Capacitive Touch.

#### Table 1.5 Files added or changed in the sample code

Name	Outline	Remarks
qe_touch_sample.c	Main processing	Changed file
r_captouch_lpm.c	Standby RAM processing	Added file
r_captouch_lpm.h	Definition of Standby RAM processing function	Added file
r_user_warm_start.c	Reset source and Deep Software Standby cancel source detection processing	Added file
r_user_warm_start.h	Definition of reset source and Deep Software Standby cancel source detection processing	Added file



## 2. Operation Conditions

This application note confirms operation based on the items and conditions stated below.

#### **Table 2.1 Operation Conditions**

Item	Description	
MCU	R7FA6M2AF3CFB (RA6M2 Group)	
Operating frequency	20MHz Middle-speed on-chip oscillator (HOCO)	
	32kHz Low-speed on-chip oscillator (LOCO)	
Operating voltage	5.0V	
Target board	RA6M2 Group Capacitive Touch Evaluation System	
	(RTK0EG0021S01001BJ)	
Integrated development environment	e <sup>2</sup> studio (2021-10)	
C compiler	GCC Arm Embedded (9.3.1.20200408)	
Operation mode	Single chip mode	
Debugger	E2 Emulator Lite	
FSP Version	Ver.3.4.0	
Sample code Version	Ver.1.00	



#### 3. Software Description

The sample code operates as follows by using the FSP driver and middleware functions.

- 1. After reset release by power on, the sample code opens rm\_touch middleware and executes offset tuning and initial calibration to be able to detect Touch On/Off.
- 2. The sample code saves information about rm\_touch middleware to Standby RAM.
- 3. Transits to Deep Software Standby mode.
- 4. After reset release from Deep Software Standby, the sample code loads the information about rm\_touch middleware from Standby RAM.
- 5. Transits to Software Standby mode.
- 6. Transits to Snooze mode by AGT counter underflow and start CTSU measurement by Snooze entry.
- 7. Save result of Touch On/Off detection.
- 8. Repeat step 2 from step 7 and the sample code flashes user LED when Touch On is detected five times in a row.

#### 3.1 Operation image

Figure 3-1 shows CPU operation mode and CTSU operation status according to the process in the sample code.

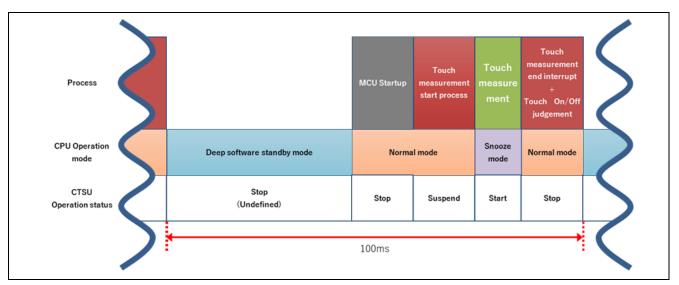


Figure 3-1 Operation image



#### 3.2 FSP driver and middleware

Table 3.1 lists FSP driver and middleware used in the sample code.

#### Table 3.1 FSP driver and middleware used in the sample code

FSP driver, middleware	Version
Board Support Package (BSP)	3.4.0
CTSU Driver (r_ctsu)	3.4.0
Capacitive Touch Middleware (rm_touch)	3.4.0
I/O Port Driver (r_ioport)	3.4.0
Timer Driver (r_agt)	3.4.0
Low Power Mode Driver (r_lpm)	3.4.0
Event Link Controller (r_elc)	3.4.0
DTC Driver (r_dtc)	3.4.0

#### 3.2.1 Standby SRAM Notes

To use Standby SRAM, add definition of Standby SRAM section to section information of linker script file according to the SRAM address and SRAM capacity of the Standby RAM described in the user's manual.

In the sample code, "script\fsp.ld" the linker script file.



## 3.3 List of Constants

The modifiable constant is show in Table 3.2.

### Table 3.2 The modifiable constant (qe\_touch\_sample.c)

Constants	Initial value	Setting
DETECTED_PRESSES	5U	Number of Touch On detection
TOUCH_BUTTON_00	1U	Bit position to check Touch On/Off of Touch Button
NO_DETECTED_PRESS	0U	Non-detection of Touch On
LED_LOOP_MAX	10U	Number of LED processing at Touch On detection
LED_CYCLE_MS	50U	LED lighting cycle at Touch On detection
RTC_STABLIZATION_TIME _US	190U	Time to wait for RTC clock to stabilize
DEEP_STBY_TIME	0xcc0	Time in deep software standby mode

#### Table 3.3 the modifiable constant (r\_user\_warm\_start.h)

Constants	Initial value	Setting
IWDT_RESET_ENABLED	0	0: Disable Independent watchdog timer reset
		1: Enable Independent watchdog timer reset
WDT_RESET_ENABLED	0	0: Disable Watchdog timer reset
		1: Enable Watchdog timer reset
VOLTAGE_MONITOR_0_R	0	0: Disable Voltage monitor 0 reset
ESET_ENABLED		1: Enable Voltage monitor 0 reset
VOLTAGE_MONITOR_1_R	0	0: Disable Voltage monitor 1 reset
ESET_ENABLED		1: Enable Voltage monitor 1 reset
VOLTAGE_MONITOR_2_R	0	0: Disable Voltage monitor 2 reset
ESET_ENABLED		1: Enable Voltage monitor 2 reset
SRAM_PARITY_RESET_EN	0	0: Disable SRAM parity error reset
ABLED		1: Enable SRAM parity error reset
SRAM_ECC_RESET_ENAB	0	0: Disable SRAM ECC error reset
LED		1: Enable SRAM ECC error reset
BUS_MPU_SLAVE_RESET	0	0: Disable Bus slave MPU error reset
_ENABLED		1: Enable Bus slave MPU error reset
BUS_MPU_MASTER_RESE	0	0: Disable Bus master MPU error reset
T_ENABLED		1: Enable Bus master MPU error reset
CPU_SP_RESET_ENABLE	0	0: Disable Stack pointer error reset
D		1: Enable Stack pointer error reset
CPU_DEEP_SW_STBY_RE	1	0: Disable Deep Software Standby reset
SET_ENABLED		1: Enable Deep Software Standby reset
CPU_SOFTWARE_RESET_	1	0: Disable Software reset
ENABLED		1: Enable Software reset



#### 3.4 List of Structures

Structures added in this sample code are shown below.

#### 3.4.1 Reset source (r\_user\_warm\_start.h)

```
/* Reset source */
typedef struct st reset source
{
    union
    {
        volatile uint16 t all;
        struct
        {
           volatile uint16 t power on reset detect flag : 1; /* Power-On
reset */
           volatile uint16 t voltage monitor 0 reset detect flag : 1; /*
Voltage monitor 0 reset */
           volatile uint16 t voltage monitor 1 reset detect flag : 1; /*
Voltage monitor 1 reset */
           volatile uint16 t voltage monitor 2 reset detect flag : 1; /*
Voltage monitor 2 reset */
           volatile uint16 t deep software standby reset flag : 1; /* Deep
Software Standby reset */
           volatile uint16 t independent watchdog timer reset detect flag :
1; /* IWDT underflow/refresh error reset */
           volatile uint16 t watchdog timer reset detect flag : 1; /* WDT
underflow/refresh error reset */
           volatile uint16 t software reset detect flag : 1; /* Software
reset */
            volatile uint16 t sram parity error reset detect flag : 1; /* SRAM
parity error reset */
           volatile uint16_t sram_ecc error reset detect flag : 1; /* SRAM
ECC error reset */
           volatile uint16 t bus slave mpu error reset detect flag : 1; /*
MPU bus slave error reset */
           volatile uint16 t bus master mpu error reset detect flag : 1; /*
MPU bus master error reset */
           volatile uint16 t sp error reset detect flag : 1; /* CPU stack
pointer monitor reset */
           volatile uint16 t cold warm start determination flag : 1; /*
Cold/Warm Start detection */
           volatile uint16 t : 2;
        } flag;
    };
} reset source t;
```



```
/* Deep Software Standby cancel source */
typedef struct st dp sw stby source
{
   union
    {
        volatile uint32 t all;
        struct
        {
            volatile uint32_t irq0_ds : 1;  /* IRQ0 */
            volatile uint32_t irq1_ds : 1;  /* IRQ1 */
            volatile uint32_t irq2_ds : 1;  /* IRQ2 */
            volatile uint32_t irq3_ds : 1; /* IRQ3 */
            volatile uint32_t irq4_ds : 1; /* IRQ4 */
            volatile uint32 t irq5 ds : 1; /* IRQ5 */
            volatile uint32 t irq6 ds : 1; /* IRQ6 */
            volatile uint32_t irq7_ds : 1;  /* IRQ7 */
            volatile uint32_t irq8_ds : 1;  /* IRQ8 */
            volatile uint32_t irq9_ds : 1;
                                             /* IRQ9 */
            volatile uint32_t irq10_ds : 1; /* IRQ10 */
            volatile uint32_t irq11_ds : 1; /* IRQ11 */
            volatile uint32 t irq12 ds : 1; /* IRQ12 */
            volatile uint32 t irq13 ds : 1; /* IRQ13 */
            volatile uint32 t irq14 ds : 1; /* IRQ14 */
            volatile uint32 t irq15 ds : 1; /* IRQ15 */
            volatile uint32_t lvd1_ds : 1; /* LVD1 */
            volatile uint32_t lvd2_ds : 1; /* LVD2 */
            volatile uint32_t rtcint_ds : 1; /* RTC Interval */
            volatile uint32 t rtcalm ds : 1; /* RTC Alarm */
            volatile uint32 t nmi ds : 1;  /* NMI */
            volatile uint32 t usbf ds : 1; /* USBFS */
            volatile uint32_t usbh_ds : 1;  /* USBHS */
volatile uint32_t agt1_ds : 2;  /* AGT1 */
        } flag;
```

#### 3.4.2 Deep Software Standby mode cancel source (r\_user\_warm\_start.h)

```
};
```

} dp sw stby source t;



## 3.5 List of Variables

Variables added and changed in this sample code are shown below.

Attribute	Variable name	Description
static uint8_t	g_button_status[DETEC TED_PRESSES]	Store result of Touch On/Off detection in last 5 times.
static uint32_t	g_button_status_index	Index of buffer to store the result of Touch On/Off detection
static uint64_t	button_status	Result of Touch On/Off detection

#### Table 3.5 Variables (r\_user\_warm\_start.h)

Attribute	Variable name	Description
volatile reset_source_t	g_reset_source	Reset source
volatile	g_dp_sw_stby_source	Deep Software Standby cancel source
dp_sw_stby_source_t		

#### Table 3.6 Variables (r\_captouch\_lpm.c)

Attribute	Variable name	Description
static uint16_t	g_power_on_reset_sym bol	Power-on reset detection flag
static uint16_t	g_touch_button_threshol d_ssram[TOUCH_CFG_ NUM_BUTTONS]	Threshold for Touch Button
static uint16_t	g_touch_button_hystere sis_ssram[TOUCH_CFG _NUM_BUTTONS]	Hysteresis for Touch Button
static uint16_t	g_touch_button_referen ce_ssram[TOUCH_CFG _NUM_BUTTONS]	Reference Value for Touch Button
static uint16_t	g_touch_button_on_cou nt_ssram[TOUCH_CFG _NUM_BUTTONS]	Touch On counter for Touch Button
static uint16_t	g_touch_button_off_cou nt_ssram[TOUCH_CFG _NUM_BUTTONS]	Touch Off counter for Touch Button
static uint32_t	g_touch_button_drift_bu f_ssram[TOUCH_CFG_ NUM_BUTTONS]	Sum of Count Value for Touch Button until Drift Correction Execution
static uint16_t	g_touch_button_drift_co unt_ssram[TOUCH_CF G_NUM_BUTTONS]	Drift Correction Interval for Touch Button
static uint8_t	g_ctsu_tuning_complete _ssram[CTSU_CFG_NU M_SELF_ELEMENTS + CTSU_CFG_NUM_MUT UAL_ELEMENTS]	Result of Initial Calibration



### RA6M2 Group

static int32_t	g_ctsu_tuning_diff_ssra m[CTSU_CFG_NUM_S ELF_ELEMENTS + CTSU_CFG_NUM_MUT UAL_ELEMENTS]	Difference between Count Value and ideal Count Value in Initial Calibration
static ctsu_ctsuwr_t	g_ctsu_ctsuwr_ssram[(C TSU_CFG_NUM_SELF _ELEMENTS + CTSU_CFG_NUM_MUT UAL_ELEMENTS) * CTSU_MULTI_NUM]	Setting value of CTSUSSC, CTSUSO0, CTSUSO1 register for Touch Button
static ctsu_self_buf_t	g_ctsu_self_raw_ssram[ CTSU_CFG_NUM_SEL F_ELEMENTS * CTSU_MULTI_NUM]	Value of CTSUSC and CTSURC register for Touch Button
static uint16_t	g_ctsu_self_data_ssram [CTSU_CFG_NUM_SEL F_ELEMENTS]	Count Value for Touch Button
static ctsu_instance_ctrl_t	g_qe_ctsu_ctrl_config_s sram	Configuration of CTSU driver control
static touch_instance_ctrl_t	g_qe_touch_ctrl_config_ ssram	Configuration of Touch middleware control
static transfer_info_t	gp_dtc_vector_table_ssr am[CTSU_VECTOR_TA BLE_ENTRIES]	Vector table for DTC
static uint32_t	dtc_vector_table_addres s_ssram	Address of Vector table for DTC
static dtc_instance_ctrl_t	g_transfer0_ctrl_ssram	Configuration of DTC for CTSUWR interrupt
static dtc_instance_ctrl_t	g_transfer1_ctrl_ssram	Configuration of DTC for CTSURD interrupt

• Variables in r\_captouch\_lpm.c are assigned to Standby RAM address.



## 3.6 List of Functions

The specification for functions added in this sample code are shown below.

3.6.1	qe_touch_	_main ()
-------	-----------	----------

qe_touch_main ()	
Outline	Main processing
Declaration	void qe_touch_main (void)
Description	Controls Touch measurement and transition to Deep Software Standby mode.
	Processes the followings according to reset source.
	<ul> <li>Power-on reset, Software reset by debugger, Reset pin</li> </ul>
	1. Open Touch middleware
	2. Initial calibration for Touch Button
	<ol><li>Save data for Touch middleware to Standby SRAM</li></ol>
	<ol><li>Transition to Deep Software Standby mode (cancel after 100ms)</li></ol>
	- Others
	<ol> <li>Load data for Touch middleware in Standby SRAM to RAM</li> </ol>
	2. Prepare Touch measurement
	3. Start Touch measurement
	<ol> <li>Blink user LED with detection Touch-On of Touch Button in 5 times continuously</li> </ol>
	5. Save data for Touch middleware to Standby SRAM
	<ol><li>Transition to Deep Software Standby mode (cancel after 100ms)</li></ol>
Argument	
Return value	-

#### 3.6.2 r\_captouch\_low\_power\_scan

r_captouch_low	/_power_scan ()	
Outline	Control touch measurement	
Declaration	void r_captouch_low_power_scan (void)	
Description	Controls touch measurement.	
	1. Start touch measurement.	
	2. Start count of AGT.	
	3. Transit to Software Standby mode.	
	4. Stop AGT count.	
Argument	· · ·	
Return value	-	



#### RA6M2 Group

## 3.6.3 r\_captouch\_low\_power\_disable\_rtc

r_captouch_low_power_disable_rtc ()		
Outline	Disable RTC	
Declaration	<pre>void r_captouch_low_power_disable_rtc (void)</pre>	
Description	Initialize RTC registers.	
Argument		
Return value	-	

## 3.6.4 R\_BSP\_WarmStart

R_BSP_WarmSt	art()	
Outline	Detect reset source and cancel source of Deep Software Standby mode	
Declaration	void R_BSP_WarmStart (bsp_warm_start_event_t event)	
Description	Detects reset source and cancel source of Deep Software Standby mode	
Argument	bsp_warm_start_event_t event Warm start event	
		BSP_WARM_SRART_RESET: After reset
		BSP_WARM_START_POST_CLOCK: After clock
		setting
		BSP_WARM_START_POST_C: After initialization
		C runtime
Return value	-	

Return value

#### 3.6.5 R\_CAPTOUCH\_LPM\_Save

R_CAPTOUCH_LPM_Save()		
Outline	Save Standby SRAM	
Declaration	void R_CAPTOUCH_LPM_Save (void)	
Description	Save data for Touch middleware to Standby SRAM	
Argument	· ·	
Return value	-	

## 3.6.6 R\_CAPTOUCH\_LPM\_Load

R_CAPTOUCH_LPM_Load()		
Outline	Load Standby SRAM	
Declaration	void R_CAPTOUCH_LPM_Load (void)	
Description	Load data for Touch middleware from Standby SRAM.	
Argument		
Return value	-	

#### 3.6.7 **R\_CAPTOUCH\_LPM\_IsPowerOnReset**

R_CAPTOUCH_LPM_IsPowerOnReset()			
Outline	Power-on reset detection		
Declaration	void R_CAPTOUCH_LPM_IsPowerOnReset (void)		
Description	Return result of Power-on reset detection.		
Argument	- ·		
Return value	-		



#### 4. Flowcharts

#### 4.1 qe\_touch\_main ()

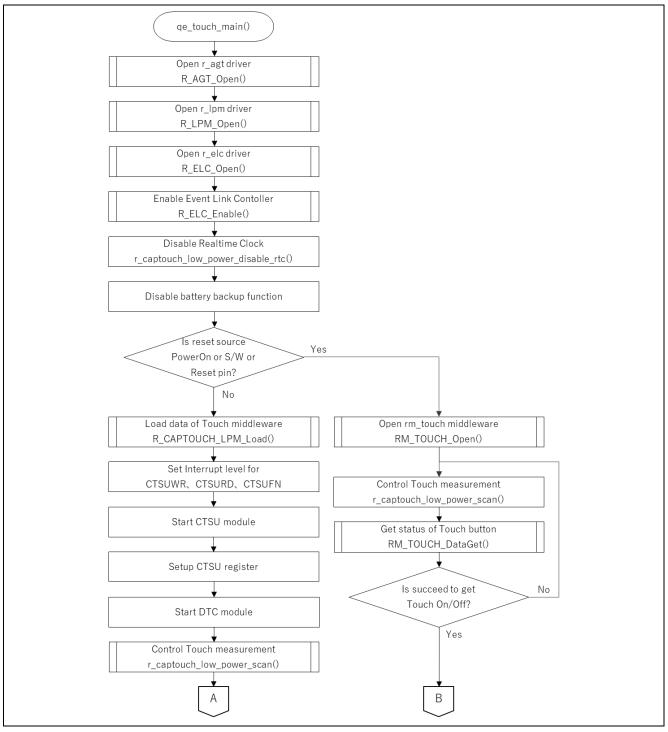


Figure 4-1 qe\_touch\_main () (1/2)



#### RA6M2 Group

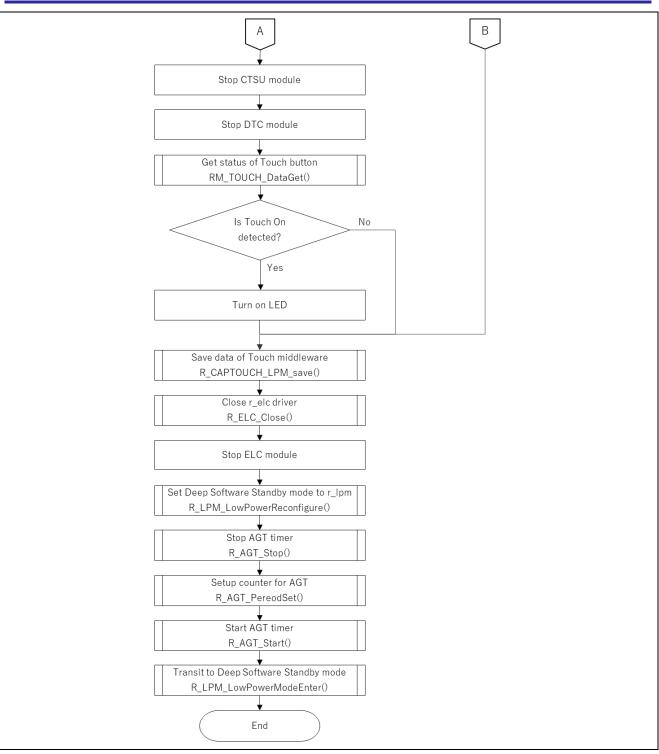


Figure 4-2 qe\_touch\_main () (2/2)



## 4.2 r\_captouch\_low\_power\_scan ()

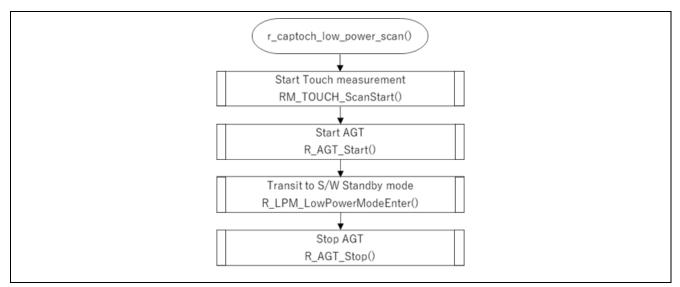


Figure 4-3 r\_captouch\_low\_power\_scan ()



## 4.3 r\_captouch\_low\_power\_disable\_rtc ()

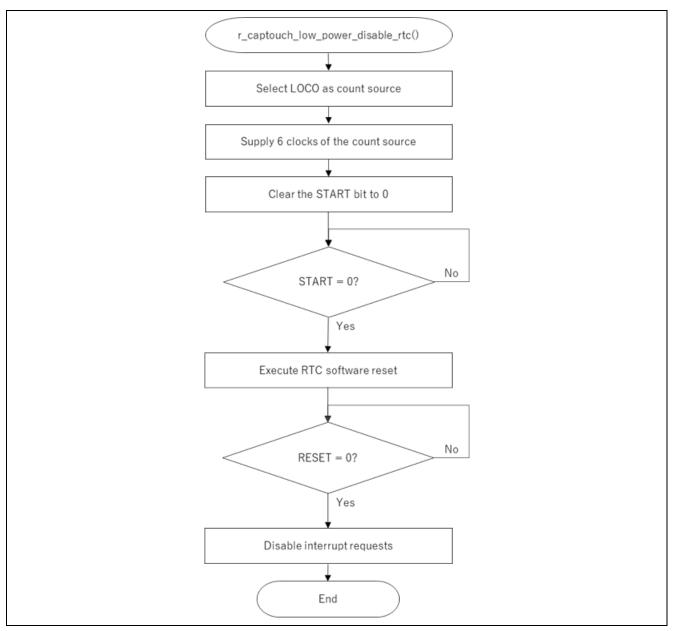


Figure 4-4 r\_captouch\_low\_power\_disable\_rtc ()



## 4.4 R\_BSP\_WarmStart ()

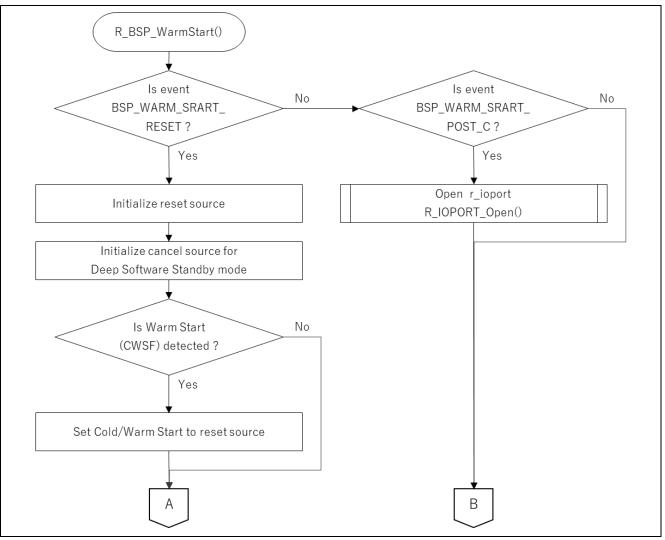


Figure 4-5 R\_BSP\_WarmStart () (1/4)



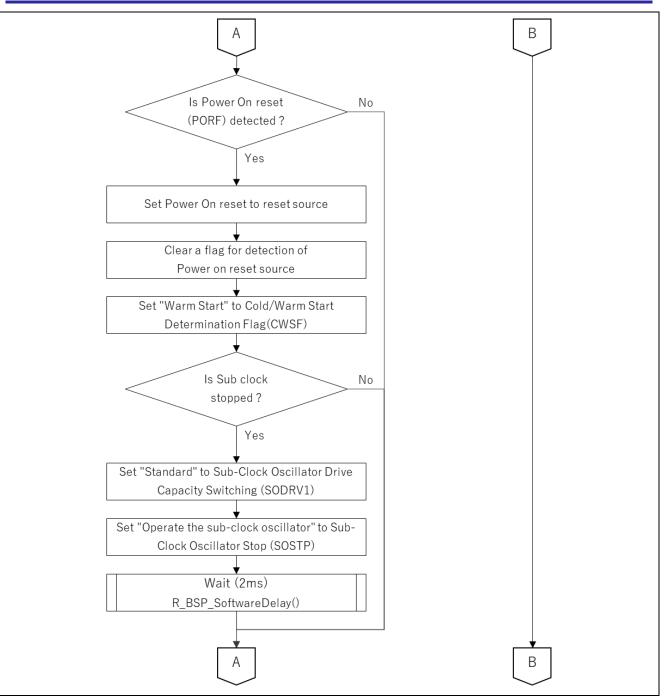


Figure 4-6 R\_BSP\_WarmStart () (2/4)



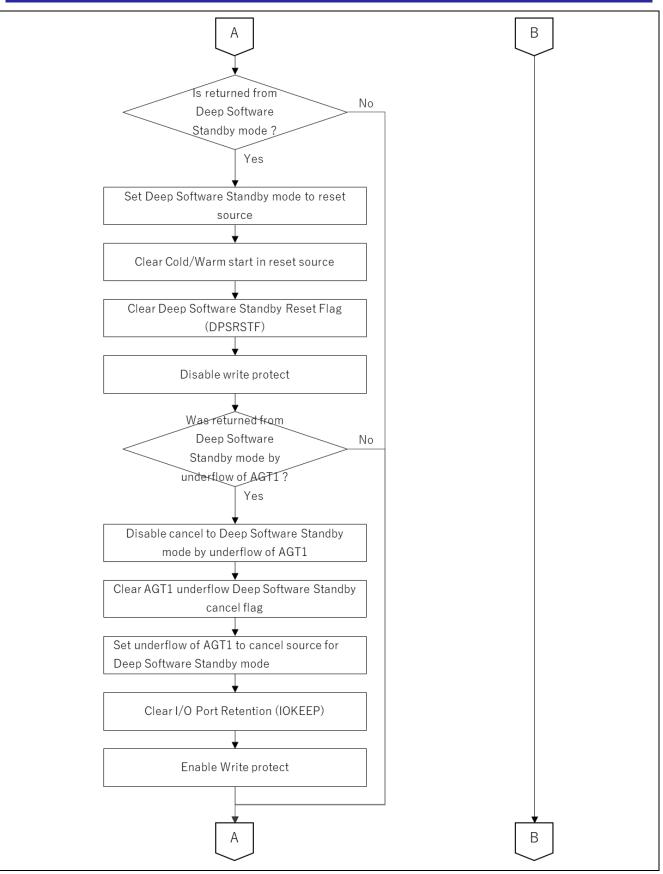


Figure 4-7 R\_BSP\_WarmStart () (3/4)



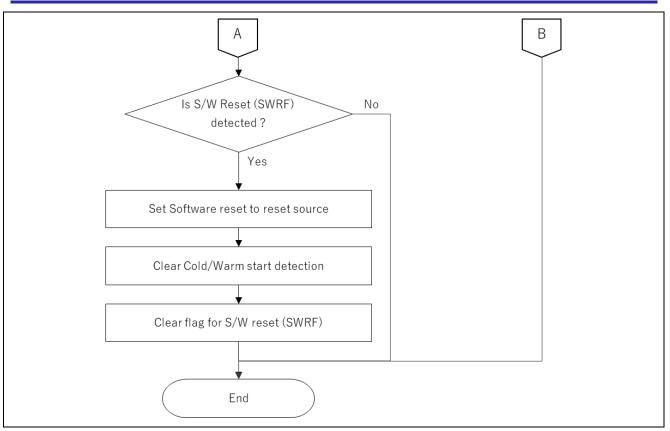


Figure 4-8 R\_BSP\_WarmStart () (4/4)



## 4.5 R\_CAPTOUCH\_LPM\_Save ()

Flowchart is shown below.

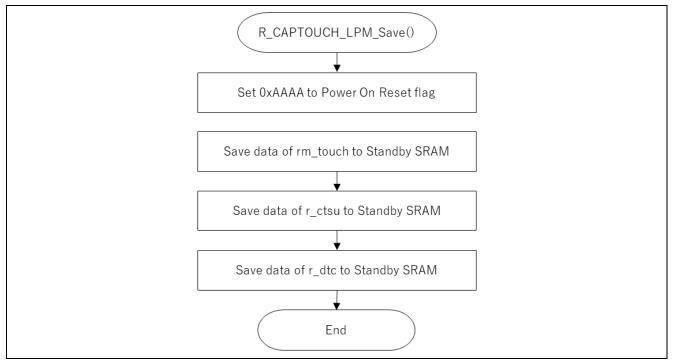


Figure 4-9 R\_CAPTOUCH\_LPM\_Save ()

## 4.6 R\_CAPTOUCH\_LPM\_Load ()

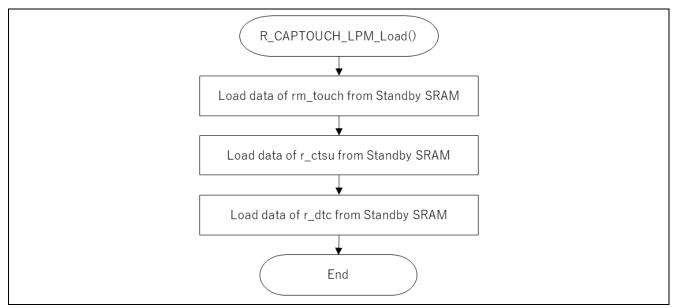


Figure 4-10 R\_CAPTOUCH\_LPM\_Load ()



## 4.7 R\_CAPTOUCH\_LPM\_IsPowerOnReset ()

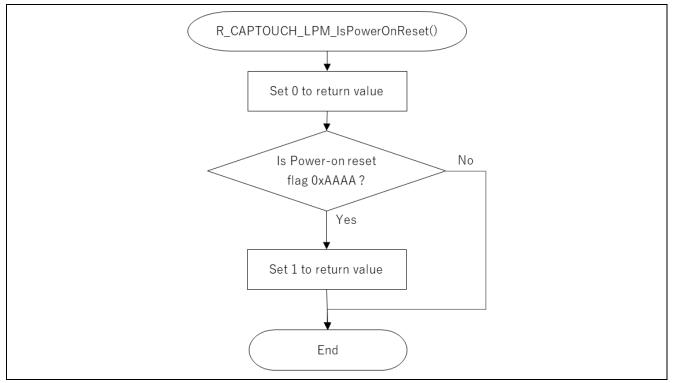


Figure 4-11 R\_CAPTOUCH\_LPM\_IsPowerOnReset ()



#### 5. Current consumption

The system configuration in the following red box shows a model of the electrostatic capacitive touch low power consumption operation described in this application note.

The system is in low power mode and only the capacitive touch button (power button) is being measured in 100ms cycles.

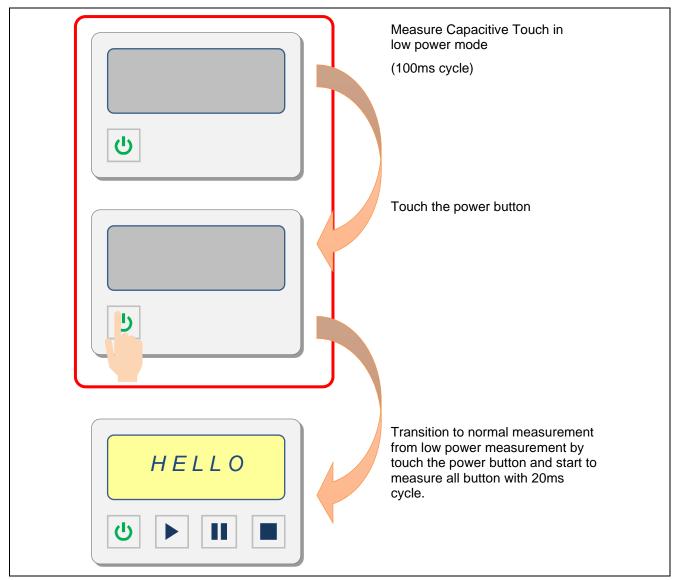


Figure 5-1 Model of the electrostatic capacitive touch low power consumption operation



## 5.1 Operation Conditions

Table 5.1 shows operation condition.

Table 5.1	Operation	Conditions
-----------	-----------	------------

Item	Description	
Operating frequency	20MHz High-speed on-chip oscillator (HOCO)	
	32kHz Low-speed on-chip oscillator (LOCO)	
System clock (ICLK)	20MHz	
Peripheral module clock A (PCLKA)	20MHz	
Peripheral module clock B (PCLKB)	20MHz	
Peripheral module clock C (PCLKC)	20MHz	
Peripheral module clock D (PCLKD)	20MHz	
Capacitive Touch measurement cycle	100ms	
Sensor drive pulse frequency	2MHz	
Touch Sensor	TS09	
CTSU Measurement Mode	Self-capacitance multi-scan mode	
CTSU Power Supply Capacity Adjustment	Normal output	
CTSU High-Pass Noise Reduction Function	Turned on	
CTSU Spectrum Diffusion Frequency Division	2MHz (0001b)	
CTSU Measurement Count	3	



#### 5.2 Measurement Environment

Table 5-2 shows equipment and software used in current consumption measurement.

#### Table 5-2 Equipment and software

Туре	Name	Use
Digital multi meter	Keithley DMM7510	Measure current consumption
Power supply	KENWOOD PA18-1.2A	Supply power to RA6M2 Cap Touch CPU board
Software	Keithley KickStart Software	Get result of current consumption measurement from Keithley DMM7510 and output the result to log-file.

## 5.3 RA6M2 Cap Touch CPU board jumper settings

Table 5-3 shows jumper settings of RA6M2 Cap Touch CPU board to measure current consumption.

#### Table 5-3 Jumper settings

Position	Circuit group	Jumper	Use
JP1	Power	Open	Measure current consumption
JP2	Power	Close 1-2 pin	Power supply from DC jack



## 5.4 RA6M2 Cap Touch CPU board

The front of RA6M2 Cap Touch CPU board are as follows.

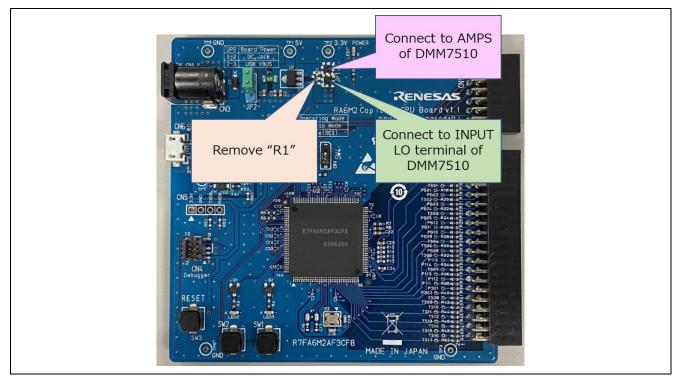


Figure 5-2 RA6M2 Cap Touch CPU board - Front part



#### 5.5 Environment to measure current consumption

Figure 5-3 shows environment to measure current consumption.

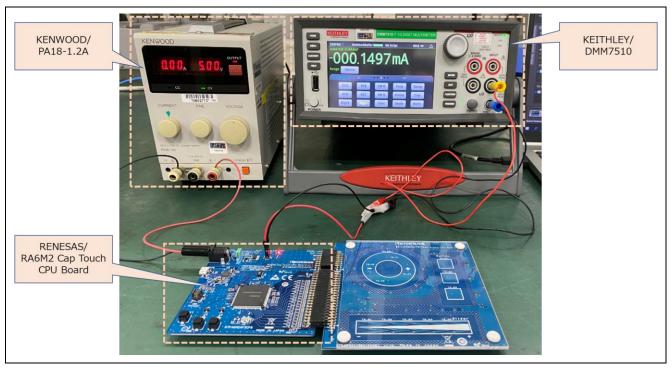


Figure 5-3 Environment to measure current consumption

### 5.6 Setting to measure current consumption

Table 5- shows settings of Keithley KickStart to measure current consumption.

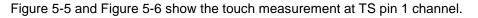
- Measurement Setting	js —		Trigger	
Function	Digitize Current	•	Trigger Mode	Immediate 👻
Range	100mA	•	Acquisition	
Aperture (s)	0.000001	Π.	Sample Rate	100000
Auto Aperture	<b>v</b>		Sample Count	100000
Display Digits	6.5	•	Start at HH:MM	2022/05/16 11:49:29 🔻 🗌
Rel			Timestamp Format	Relative 👻

Table 5-4 Settings of Keithley KickStart to measure current consumption



## 5.7 Current Consumption Results

Figure 5-5 to Figure 5-6 show the current consumption waveforms for a series of operations in which the CPU operation mode transitions to Deep Standby mode, Normal mode(MCU wake up, Touch measurement start process), Snooze mode (touch measurement processing) and Normal mode (Touch measurement end processing and Touch On/Off judgment processing).



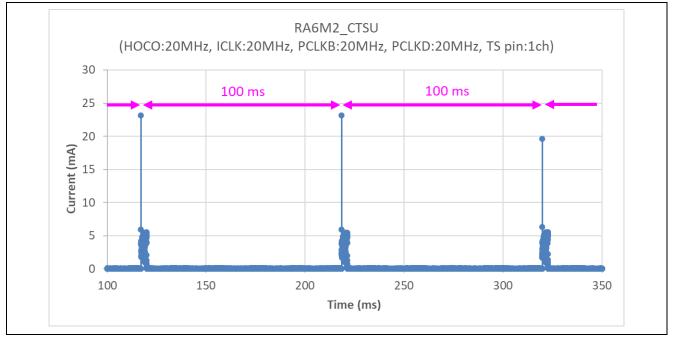


Figure 5-5 Current consumption waveform (1/2)

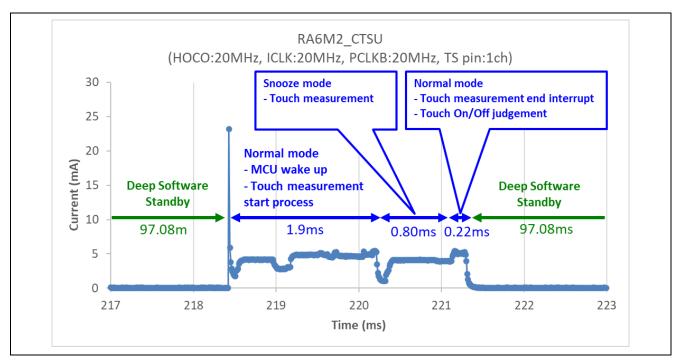


Figure 5-6 Current consumption waveform (2/2)

#### 5.8 Current Consumption Calculation Resalts

The average current consumption of TS pin 1 channel measured with a touch measurement cycle of 100ms is shown below (Figure 5-7).



Figure 5-7 Timing of actual program

Current consumption (touch measurement cycle of 100ms) = 153.322 µA



#### RA6M2 Group

#### 6. References

User's Manual: Hardware RA6M2 User's Manual Hardware R01UH0885 (The latest version can be downloaded from the Renesas Electronics website.)

Technical Update/Technical News

(The latest version can be downloaded from the Renesas Electronics website.)

User's Manual: Development Tools

(The latest version can be downloaded from the Renesas Electronics website.)

User's Manual: RA6M2 MCU Group Capacitive Touch Evaluation System (The latest version can be downloaded from the Renesas Electronics website.)



## **Revision History**

		Description	
Rev.	Date	Page	Summary
1.00	Jun.30.22	-	First edition issued



# General Precautions in the Handling of Microprocessing Unit and Microcontroller Unit Products

The following usage notes are applicable to all Microprocessing unit and Microcontroller unit products from Renesas. For detailed usage notes on the products covered by this document, refer to the relevant sections of the document as well as any technical updates that have been issued for the products.

#### 1. Precaution against Electrostatic Discharge (ESD)

A strong electrical field, when exposed to a CMOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop the generation of static electricity as much as possible, and quickly dissipate it when it occurs. Environmental control must be adequate. When it is dry, a humidifier should be used. This is recommended to avoid using insulators that can easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors must be grounded. The operator must also be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions must be taken for printed circuit boards with mounted semiconductor devices.

#### 2. Processing at power-on

The state of the product is undefined at the time when power is supplied. The states of internal circuits in the LSI are indeterminate and the states of register settings and pins are undefined at the time when power is supplied. In a finished product where the reset signal is applied to the external reset pin, the states of pins are not guaranteed from the time when power is supplied until the reset process is completed. In a similar way, the states of pins in a product that is reset by an on-chip power-on reset function are not guaranteed from the time when power is supplied until the power is supplied until the power is supplied until the power reaches the level at which resetting is specified.

3. Input of signal during power-off state

Do not input signals or an I/O pull-up power supply while the device is powered off. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Follow the guideline for input signal during power-off state as described in your product documentation.

4. Handling of unused pins

Handle unused pins in accordance with the directions given under handling of unused pins in the manual. The input pins of CMOS products are generally in the high-impedance state. In operation with an unused pin in the open-circuit state, extra electromagnetic noise is induced in the vicinity of the LSI, an associated shoot-through current flows internally, and malfunctions occur due to the false recognition of the pin state as an input signal become possible.

5. Clock signals

After applying a reset, only release the reset line after the operating clock signal becomes stable. When switching the clock signal during program execution, wait until the target clock signal is stabilized. When the clock signal is generated with an external resonator or from an external oscillator during a reset, ensure that the reset line is only released after full stabilization of the clock signal. Additionally, when switching to a clock signal produced with an external resonator or by an external oscillator while program execution is in progress, wait until the target clock signal is stable.

#### 6. Voltage application waveform at input pin

Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between  $V_{IL}$  (Max.) and  $V_{IH}$  (Min.) due to noise, for example, the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between  $V_{IL}$  (Max.) and  $V_{IH}$  (Min.)

7. Prohibition of access to reserved addresses

Access to reserved addresses is prohibited. The reserved addresses are provided for possible future expansion of functions. Do not access these addresses as the correct operation of the LSI is not guaranteed.

8. Differences between products

Before changing from one product to another, for example to a product with a different part number, confirm that the change will not lead to problems. The characteristics of a microprocessing unit or microcontroller unit products in the same group but having a different part number might differ in terms of internal memory capacity, layout pattern, and other factors, which can affect the ranges of electrical characteristics, such as characteristic values, operating margins, immunity to noise, and amount of radiated noise. When changing to a product with a different part number, implement a systemevaluation test for the given product.

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